

United States Patent [19]

Kida

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[45] Date of Patent: **** Jul. 17, 1990**

[54] **PROBE FOR ELECTRONIC CLINICAL THERMOMETER**

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[73] Assignee: **Terumo Kabushiki Kaisha**, Tokyo, Japan

[**] Term: **14 Years**

[21] Appl. No.: **103,260**

[22] Filed: **Sep. 30, 1987**

[30] **Foreign Application Priority Data**

Jul. 31, 1987 [JP] Japan 62-30900

[52] U.S. Cl. **D10/57**

[58] Field of Search D10/50, 57, 60; 728/736, 207.14; 374/100, 106, 106, 132, 151, 158, 159, 164, 170, 179, 185, 194, 208, 209

[56] **References Cited**

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[57] **CLAIM**

The ornamental design for a probe for electronic clinical thermometer, as shown and described.

DESCRIPTION

FIG. 1 is a top, front, and left side perspective view of an electronic clinical thermometer showing my new design;
FIG. 2 is a front elevational view;
FIG. 3 is a rear elevational view;
FIG. 4 is a right side elevational view;
FIG. 5 is a top plan view;
FIG. 6 is a bottom plan view; and
FIG. 7 is an enlarged scale cross-sectional view as taken from line VII—VII of FIG 2 thereof.

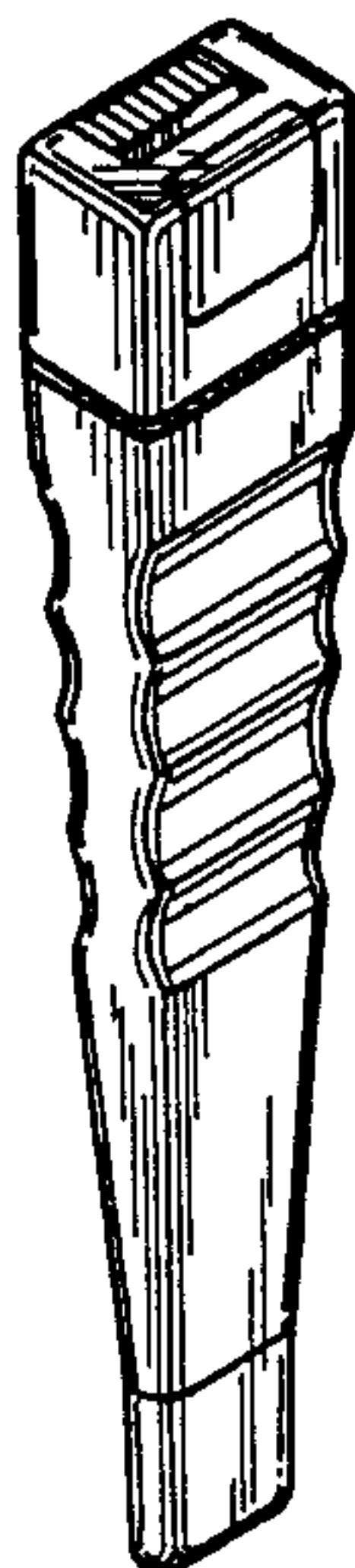


FIG. 1

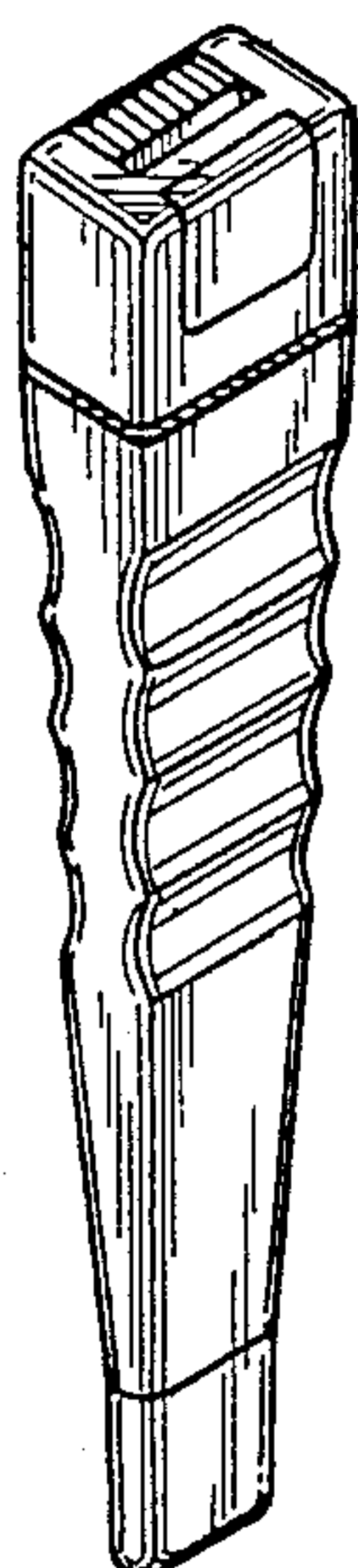


FIG. 2

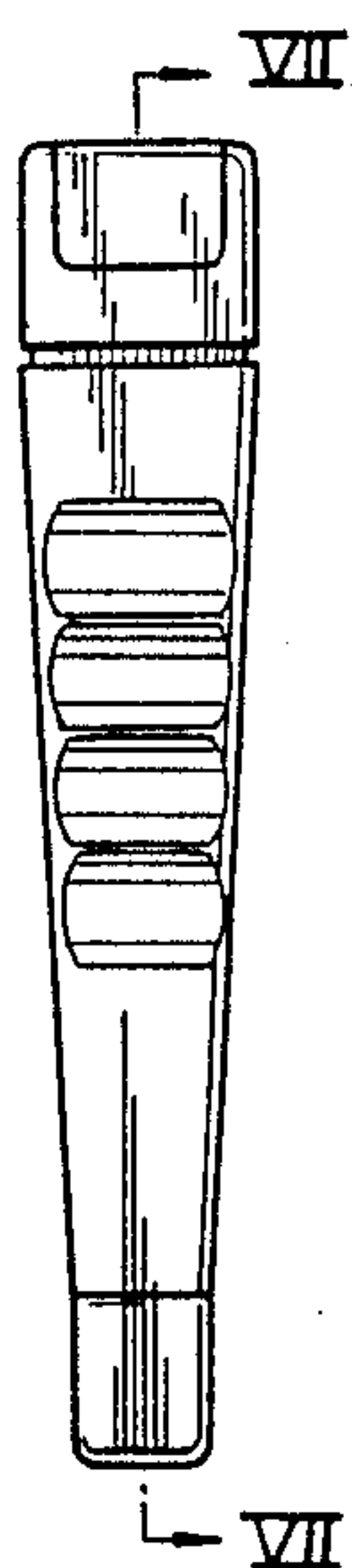


FIG. 3

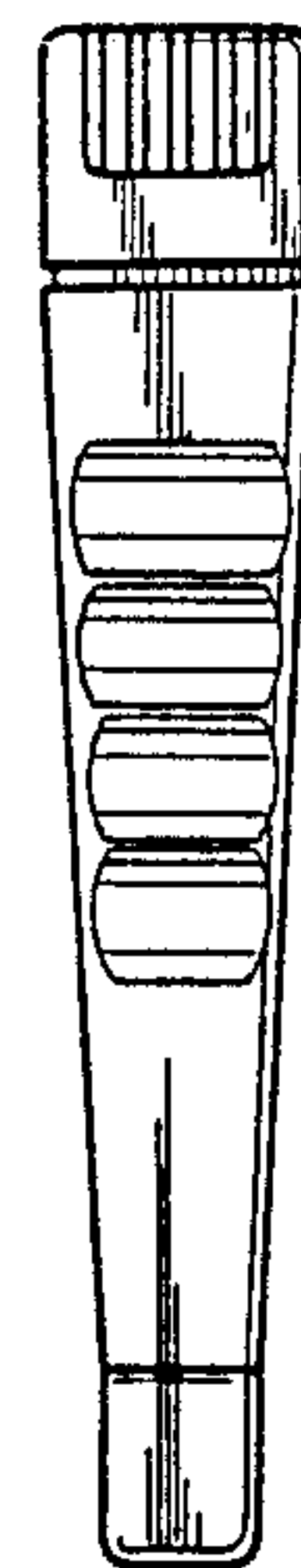


FIG. 4



FIG. 5



FIG. 6



FIG. 7

